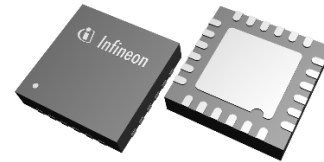


# BGAP3D30H

## Pre-Driver for Wireless Infrastructure Applications

### Features

- Operation frequency range: 3100 to 4200 MHz
- High gain: 38.5 dB
- High output P1dB: 31 dBm
- High ACLR: 47 dBc
- Adjustable bias current (via external resistor)
- Fast switching for TDD support
- 100Ω differential input
- 5V supply voltage
- 24 pins leadless QFN package (4.0 x 4.0 mm<sup>2</sup>)
- BiCMOS Technology



PG-VQFN-24 4x4mm<sup>2</sup>

- ✓ RoHS
- ⊘ Halogen-Free
- 🌿 Green
- ⊘ Lead-Free

### Potential applications

- 4G/5G Cellular Infrastructure
  - Massive MIMO systems
  - Small cells

### Product validation

Qualified for industrial applications according to the relevant tests of JEDEC47/20/22

### Description

The BGAP3D30H is a stand-alone packaged two-stage pre-driver amplifier. It is designed to be used in a TX line-up of a base station radio unit as a pre-driver for Doherty power amplifier. The BGAP3D30H is equipped with a tunable bias circuitry controlled by external resistor. This enables to optimize balance between linearity and power consumption in the target application. The input is 100Ω differential, the output is 50Ω single-ended.

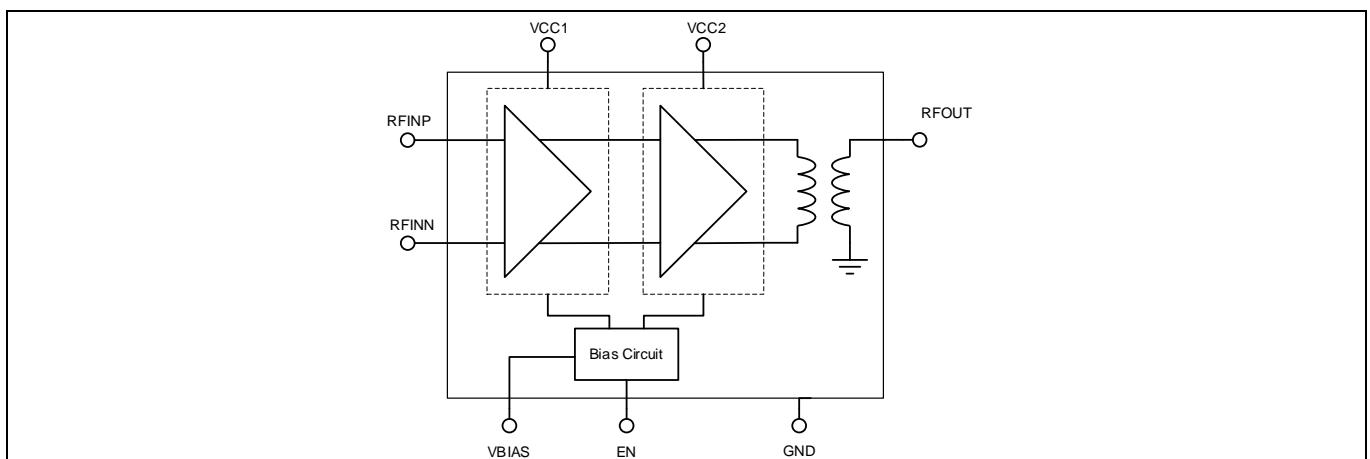
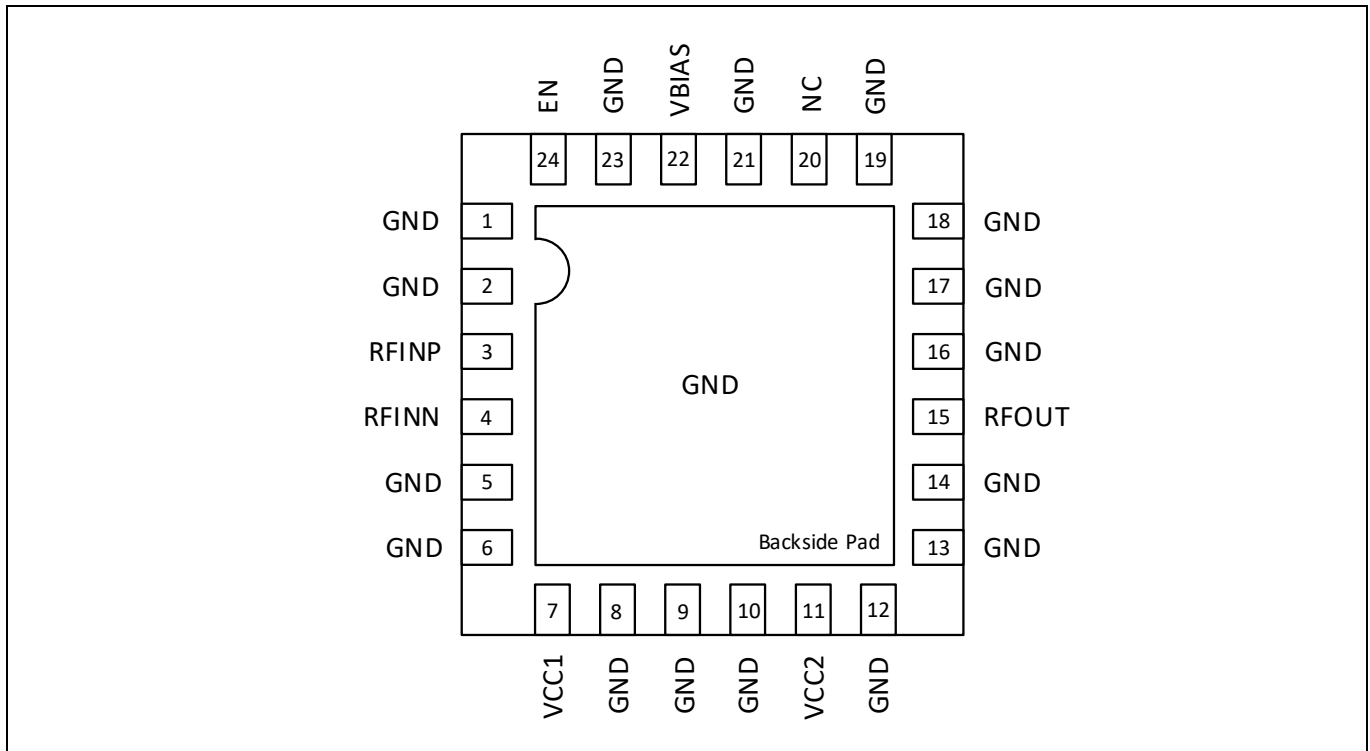


Figure 1 BGAP3D30H Block Diagram

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# 1 Pin Configuration



**Figure 2 Pin assignment of BGAP3D30H - Top View**

**Table 1 Pin definition and function**

Pin No.	Name	Function
1, 2, 5, 6, 8-10, 12-14, 16-19, 21, 23	GND	Ground connection
3	RFINP	RF Input +
4	RFINN	RF Input -
7	VCC1	1 <sup>st</sup> stage DC voltage supply
11	VCC2	2 <sup>nd</sup> stage DC voltage supply
15	RFOUT	RF Output
20	NC	Not connected internally. It can be left floating or connected to ground
22	VBIAS	Bias adjust for linearity/power consumption trade-off (pull-down resistor to GND)
24	EN	Chip enable/disable
Backside Pad	GND	Ground connection

## 2 Absolute Maximum Ratings

**Table 2 Absolute Maximum Ratings<sup>1</sup>**

Parameter	Symbol	Values			Unit	Note
		Min.	Typ.	Max.		
Supply Voltage	$V_{CC}$	-0.5	–	5.5	V	–
Enable Voltage	$V_{EN}$	-0.3	–	$V_{CCMax}$	V	–
Storage Temperature	$T_{STG}$	-45	–	150	°C	–
Junction Temperature	$T_J$	-40	–	170	°C	–
DC voltage at RF Ports	$V_{RF,DC}$	0	–	0	V	–
RF Input Power CW	$P_{IN,CW}$	–	–	6	dBm	–

<sup>1</sup> All voltages refer to GND node unless otherwise specified

**Warning: Stresses above the maximum values listed here may cause permanent damage to the device. Maximum ratings are absolute ratings; exceeding only one of these values may cause irreversible damage to the integrated circuit. Exposure to conditions at or below absolute maximum rating but above the specified maximum operation conditions may affect device reliability and life time. Functionality of the device might not be given under these conditions.**

### 3 Specifications

#### 3.1 Recommended Operating Conditions

**Table 3** Operational ratings<sup>1</sup>

Parameter	Symbol	Values			Unit	Note
		Min.	Typ.	Max.		
Supply Voltage	$V_{CC}$	4.75	–	5.25	V	–
Enable Voltage OFF	$V_{EN,OFF}$	0	–	0.69	V	–
Enable Voltage ON	$V_{EN,ON}$	1.07	–	$V_{CC}$	V	–
Operating Temperature	$T_S$	-40	–	115	°C	Solder joint temperature
Average Output Power	$P_{avg}$	–	18	18.5	dBm	

<sup>1</sup> All voltages refer to GND node unless otherwise specified

#### Power-up and power-down sequences

The following sequences are required to be respected during power-up/down of the device.

Power-up sequence: 1. VCC1 and VCC2 -> on; 2. EN -> on.

Power-down sequence: 1. EN -> off; 2. VCC1 and VCC2 -> off.

**Deviating from these sequences may cause permanent damage.**

#### 3.2 ESD Ratings

**Table 4** ESD Ratings<sup>1</sup>

Parameter	Symbol	Values			Unit	Note
		Min.	Typ.	Max.		
ESD robustness HBM <sup>2</sup>	$V_{ESD,HBM}$	–	–	1	kV	On all pins
ESD robustness CDM <sup>3</sup>	$V_{ESD,CDM}$	–	–	250	V	On all pins

<sup>1</sup> All voltages refer to GND node unless otherwise specified

<sup>2</sup> Human Body Model ANSI/ESDA/JEDECJS-001 (R = 1.5kΩ, C = 100pF)

<sup>3</sup> Field-Induced Charged-Device Model ANSI/ESDA/JEDECJS-002. Simulates charging/discharging events that occur in production equipment and processes. Potential for CDM ESD events occurs whenever there is metal-to-metal contact in manufacturing.

#### 3.3 External components

**Table 5** External components

Parameter	Symbol	Value			Unit	Note
		Min.	Typ.	Max.		
Bias adjust resistor	$R_{BIAS}$	16.2	20	26.1	kΩ	For I <sub>CC</sub> control range of ±20%

#### 3.4 Thermal Information

**Table 6** Thermal resistance

Parameter	Symbol	Value	Unit	Note
Thermal Resistance: Junction – Solder pad	$R_{th,J-S}$	22.9	°K/W	At $T_{amb} = 25^{\circ}C$

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**3.5 Electrical characteristics**

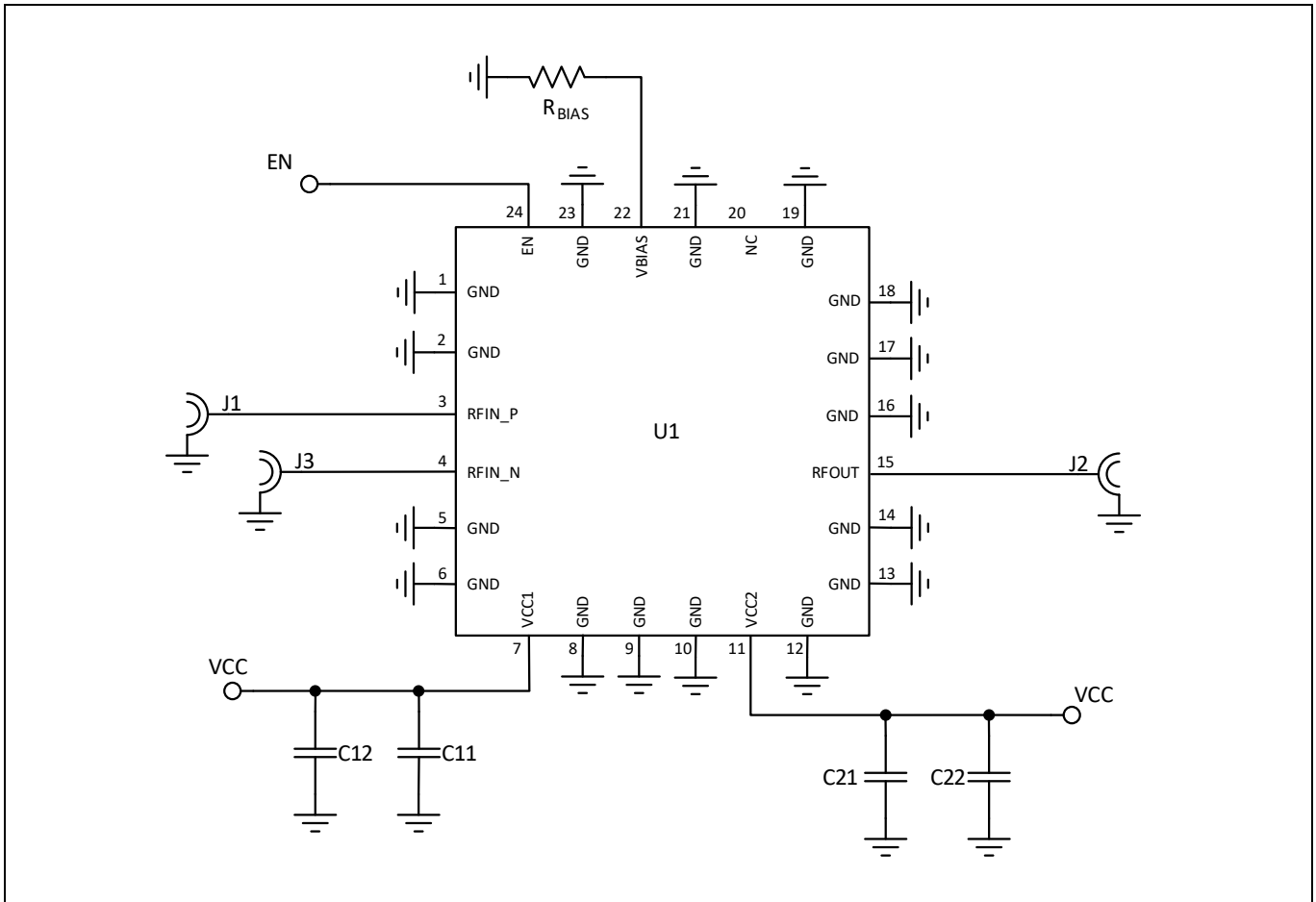
**Table 7 Electrical characteristics<sup>1,2</sup> ( $R_{BIAS} = 20k\Omega$ )**

Parameter	Symbol	Values			Unit	Note
		Min.	Typ.	Max.		
RF Frequency	$f_{RF}$	3100	–	4200	MHz	–
Current Consumption OFF	$I_{CC,OFF}$	–	–	1.3	mA	–
Current Consumption ON	$I_{CC,ON}$	–	–	257	mA	No RF input signal
Current Consumption ON	$I_{CC,ON}$	–	–	315	mA	w/ RF output signal 18dBm
Input Return Loss	$RL_{IN}$	–	16	–	dB	At differential 100 $\Omega$ input
Output Return Loss	$RL_{OUT}$	–	30	–	dB	At single-ended 50 $\Omega$ output
Gain	$G$	37.8	40.1	–	dB	–
Gain Flatness	$G_{FLAT}$	–	–	0.35	dB	Defined in any 100 MHz within operational band
Output P1dB	$OP_{1dB}$	29.4	31.4	–	dBm	–
Output IP3	$OIP_3$	–	41.1	–	dBm	PIN1=PIN2=-30dBm, $\Delta f=1$ MHz
Adjacent Channel Leakage Ratio	$ACLR$	–	-53.8	-41.5	dBc	20MHz E-TM1.1 with 10.2 dB PAPR @Pout=18 dBm
Common Mode Rejection Ratio	$CMRR$	30	–	–	dB	–
Noise Figure	$NF$	–	–	3.3	dB	–
Switching ON Time	$T_{ON}$	–	–	1.8	$\mu s$	Gain within 0.1dB amplitude and 1° phase of final value
Switching OFF Time	$T_{OFF}$	–	–	0.3	$\mu s$	Gain within <5% and power dissipation <10% than in ON state

<sup>1</sup> All voltages refer to GND node unless otherwise specified

<sup>2</sup> Typical values: T=25°C,  $V_{CC}=5V$ ,  $f_{RF}=3.6GHz$ ,  $R_{BIAS}=20k\Omega$ . Min/Max values defined over process, voltage, temperature and frequency variations based on characterization.

## 4 Application Board

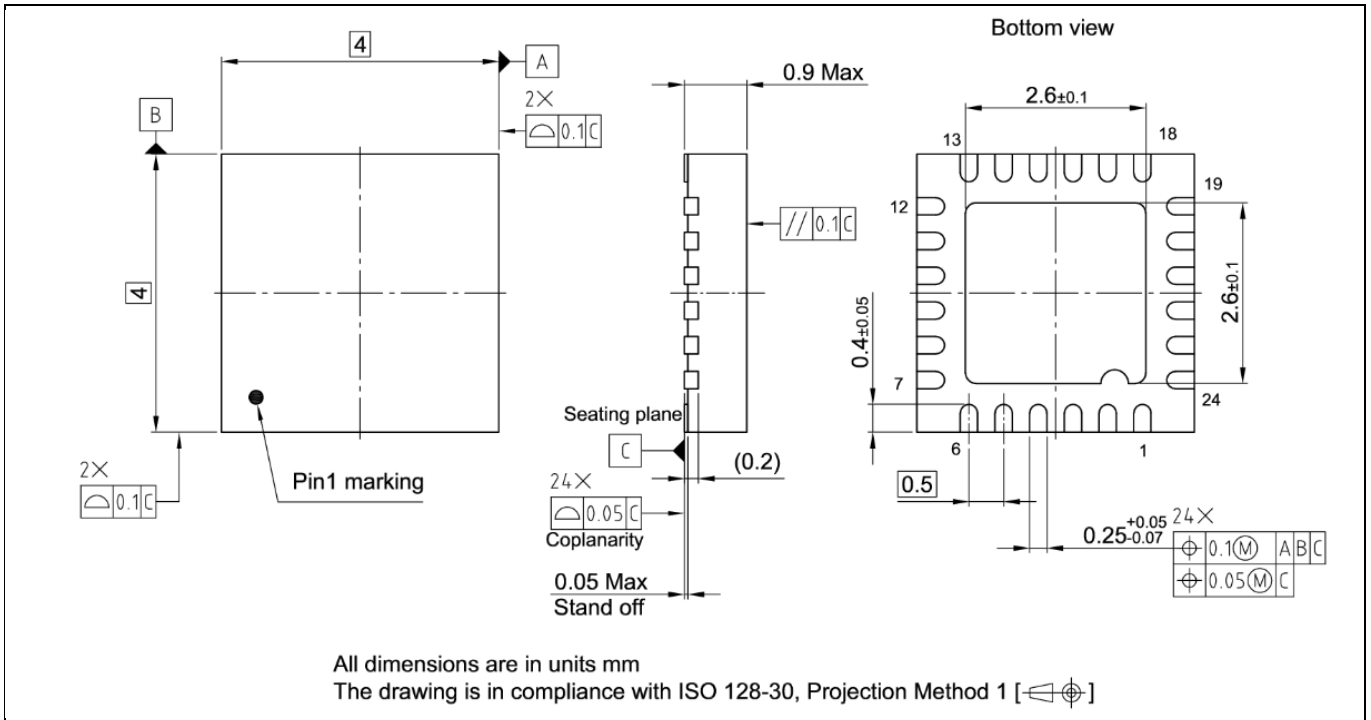


**Figure 3** BGAP3D30H Application schematic diagram

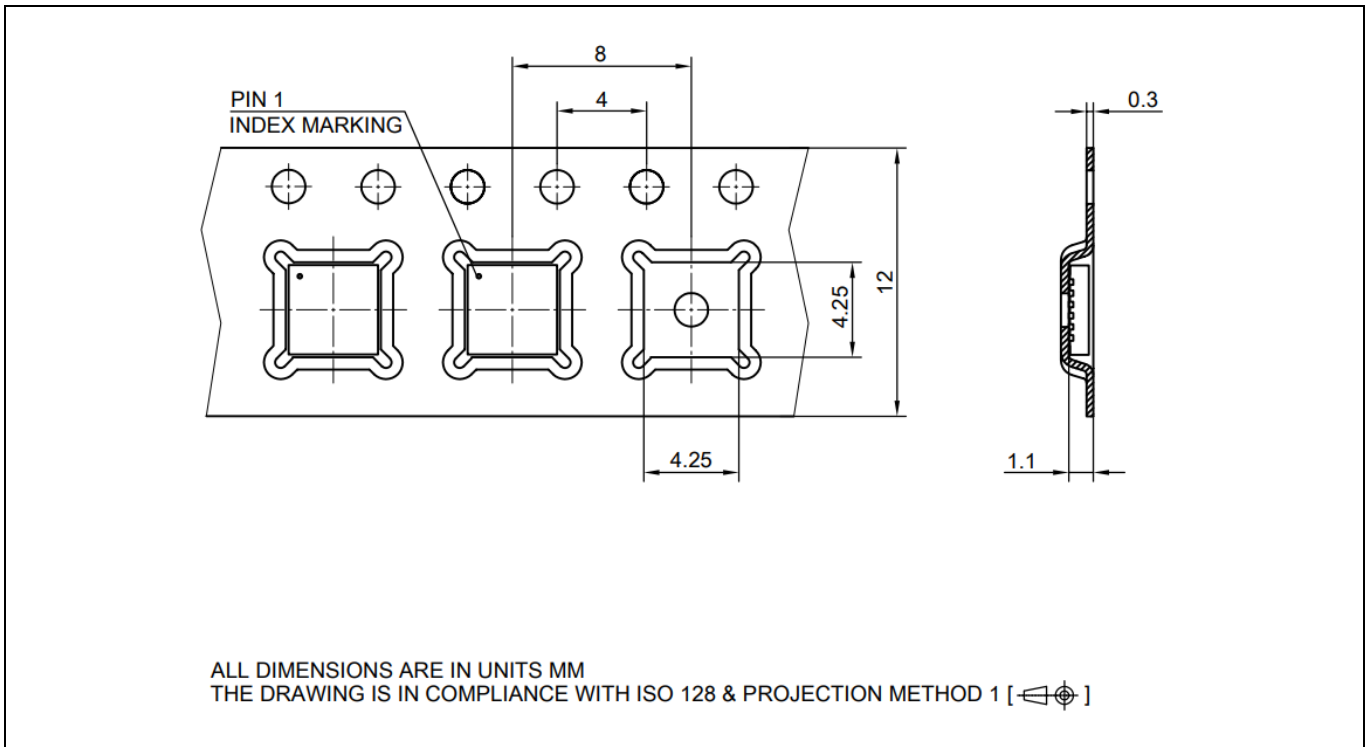
**Table 8** Bill of Materials

Name	Value	Description	Part Number	Manufacturer
C11, C21	10 nF	Capacitor, X7R, 0402	KGM05AR71C103KH	Kyocera
C12, C22	1 uF	Capacitor, X7R, 0402	GRM155Z71A105KE01D	Murata
R <sub>BIAS</sub>	20kΩ	Resistor, 0402, +/-1%	MCS04020C2002FE000	Vishay
J1, J2, J3	-	Connector, SMA	-	-
U1	-	Pre-Driver, PG-VQFN-24-20	BGAP3D30H	Infineon

## 5 Package Information



**Figure 4 PG-VQFN-24-20 Package Outline (4.0mm x 4.0mm x 0.9mm)**



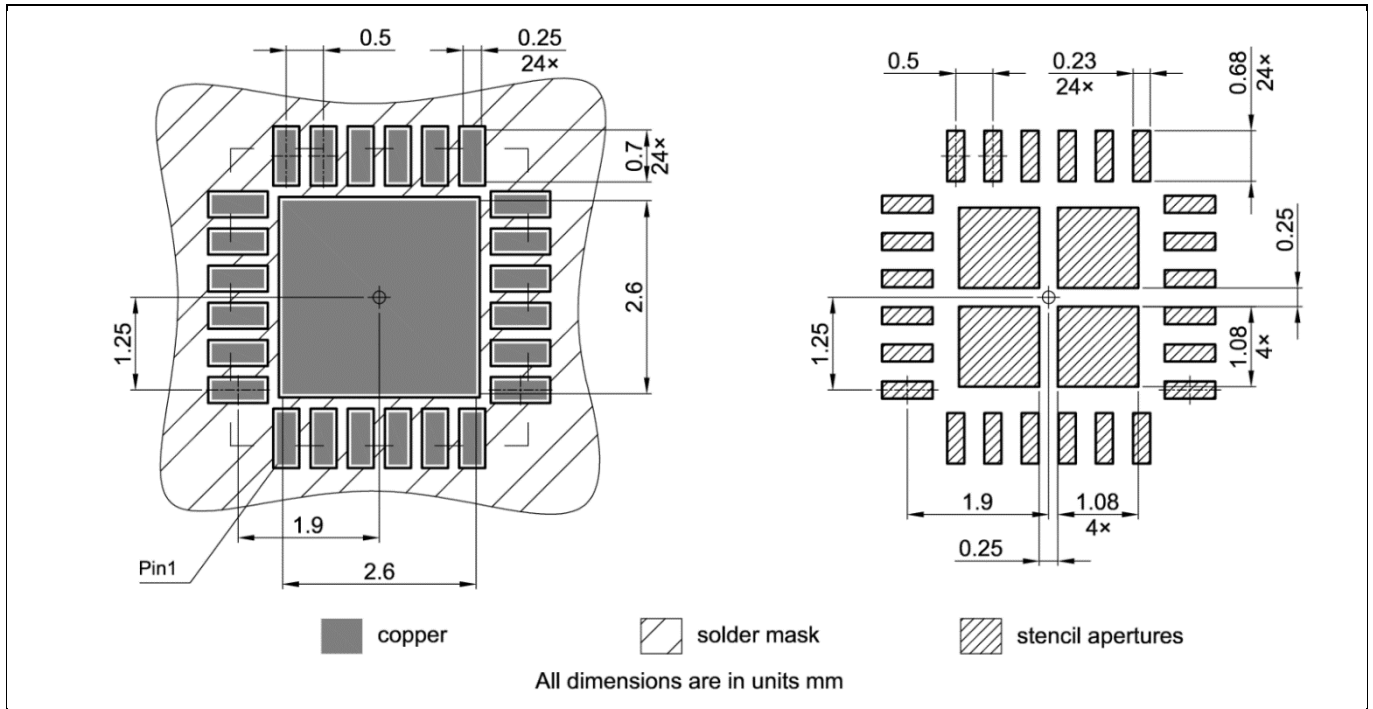
**Figure 5 PG-VQFN-24-20 Carrier Tape**



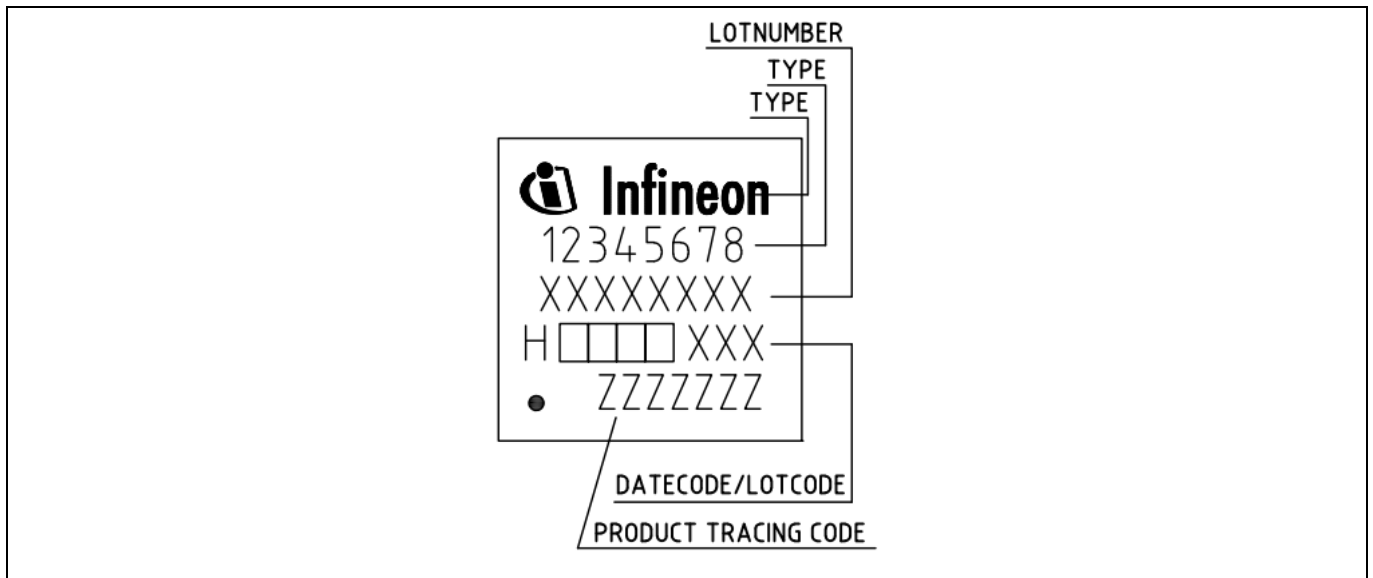
# BGAP3D30H

## Pre-Driver for Wireless Infrastructure Applications

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**Figure 6 PG-VQFN-24-20 Footprint Recommendation**



**Figure 7 Marking Specification PG-VQFN-24-20 (top view)**

Product Name	Marking Type	Datecode
BGAP3D30H	BP3D3H	YYWW (YY=year, WW=week)

**Revision history**

**Revision history**

<b>Document version</b>	<b>Date of release</b>	<b>Description of changes</b>
V1.0	2023-06-16	First draft
V1.1	2023-06-19	Carrier Tape dimensions added
V1.2	2023-07-06	Bias resistor connection, Rth update
V1.3	2024-01-09	Bias resistor connection, Rth update
V2.0	2024-06-24	Table 2: VBIAS removed Table 3: adding Average Output Power range data Table 5: added min/max values for RBIAS Table 6: Rth changed to new value and condition Table 7: values and typo, adding table 2 line for $P_{avg}$ , added Rbias =20k in header information. Table 8 component details added Added Figure 6, 7 for package and footprint

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